



# EMI TEST REPORT

Test Report No. : 31JE0238-HO-B

**Applicant** : SHARP CORPORATION  
**Type of Equipment** : Cellular Phone  
**Model No.** : SH-03D  
**FCC ID** : APYHRO00154  
**Test standard** : FCC Part 15 Subpart B 2011 Class B  
**Test Result** : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

**Date of test:** October 13, 2011

**Representative test engineer:**

*H. Kukita*

Hiroshi Kukita  
Engineer of WiSE Japan,  
UL Verification Service

**Approved by:**

*M. Nishiyama*

Masanori Nishiyama  
Leader of WiSE Japan,  
UL Verification Service



NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. \*As for the range of Accreditation in NVLAP, you may refer to the WEB address, <http://www.ul.com/japan/jpn/pages/services/emc/about/mark1/index.jsp#nvlap>

**UL Japan, Inc.**

**Head Office EMC Lab.**

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## **SECTION 1: Customer information**

Company Name : SHARP CORPORATION  
Address : 2-13-1 Iida, Hachihonmatsu, Higashi-Hiroshima City, Hiroshima,  
739-0192 Japan  
Telephone Number : +81-82-420-1825  
Facsimile Number : +81-82-420-1829  
Contact Person : Kazuo Sugimoto

## **SECTION 2: Equipment under test (E.U.T.)**

### **2.1 Identification of E.U.T.**

Type of Equipment : Cellular Phone  
Model No. : SH-03D  
Serial No. : Refer to Section 4, Clause 4.2  
Receipt Date of Sample : October 13 2011  
Country of Mass-production : Japan  
Condition of EUT : Production prototype  
(Not for Sale: This sample is equivalent to mass-produced items.)  
Modification of EUT : No Modification by the test lab

### **2.2 Product description**

Feature of EUT : Five Band WCDMA(FDD I / V / VI / IX / XIX) and Tri-band  
GSM(900/1800/1900) Dual mod Cellular Phone / Bluetooth/W-LAN ,  
Felica & 1.5GHz Band Satellite Receiver (GPS) enable  
- GSM (EU:900/1800M, 1900M)  
- WCDMA (EU:2000M, US:850M, JPN: 800/1700/2000)  
Clock frequencies in the system : CPU: 1.248GHZ  
Source oscillation: 48MHz

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### **SECTION 3: Test specification, procedures & results**

#### **3.1 Test specification**

Test Specification : FCC Part 15 Subpart B: 2011, final revised on July 8, 2011 and effective August 8, 2011

Title : FCC 47CFR Part15 Radio Frequency Device  
Subpart B Unintentional Radiators

#### **3.2 Procedures and results**

<b>Item</b>	<b>Test Procedure</b>	<b>Limits</b>	<b>Deviation</b>	<b>Worst margin</b>	<b>Result</b>
Conducted emission	ANSI C63.4: 2003 7. AC powerline conducted emission measurements	Class B	N/A	[QP] 11.9dB 1.70560MHz, L [AV] 10.7dB 1.71210MHz, N	Complied
Radiated emission	ANSI C63.4: 2003 8. Radiated emission measurements	Class B	N/A	7.0dB 798.240MHz, Vertical, QP	Complied

\*Note: UL Japan, Inc's EMI Work Procedure 13-EM-W0420.

#### **3.3 Addition to standard**

No addition, exclusion nor deviation has been made from the standard.

### 3.4 Uncertainty

#### EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Conducted emission (+dB)
	150kHz-30MHz
No.1	3.5dB
No.2	3.6dB
No.3	3.6dB
No.4	3.6dB

Test room (semi-anechoic chamber)	Radiated emission						
	(3m*)(+dB)				(1m*)(+dB)		(0.5m*)(+dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -10GHz	10GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	4.2dB	5.0dB	5.1dB	5.6dB	5.9dB	4.4dB	4.3dB
No.2	4.1dB	5.2dB	5.1dB	5.7dB	5.8dB	4.3dB	4.2dB
No.3	4.5dB	5.0dB	5.2dB	5.7dB	5.8dB	4.5dB	4.2dB
No.4	4.7dB	5.2dB	5.2dB	5.7dB	5.8dB	5.1dB	4.2dB

\*3m/1m/0.5m = Measurement distance

#### Conducted Emission test

The data listed in this test report has enough margin, more than the site margin.

#### Radiated emission test(3m)

The data listed in this test report has enough margin, more than the site margin.

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### 3.5 Test Location

UL Japan, Inc. Head Office EMC Lab. \*NVLAP Lab. code: 200572-0  
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN  
Telephone : +81 596 24 8116 Facsimile : +81 596 24 8124

	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

\* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

### 3.6 Data of EMI, Test instruments, and Test set up

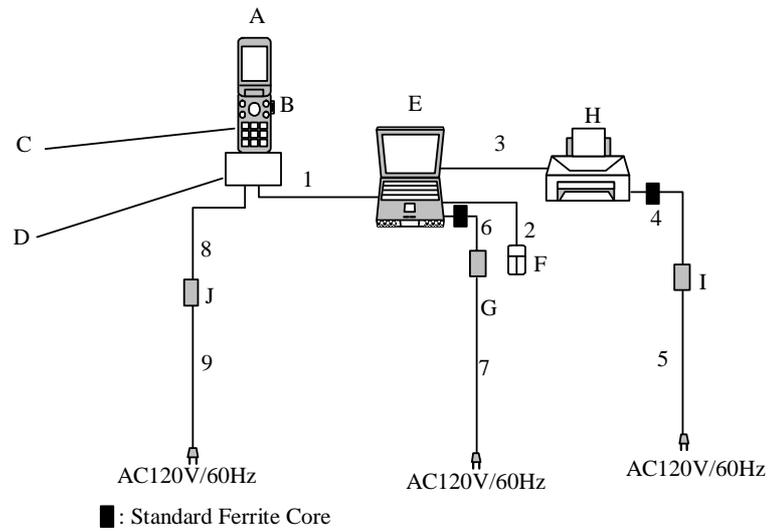
Refer to APPENDIX.

## **SECTION 4: Operation of E.U.T. during testing**

### **4.1 Operating modes**

The mode(s) : 1) USB Data Com Mode  
The USB data is communicated between EUT and Personal computer (Pair of EUT).  
2) Standby Mode  
Standby state for USB communication.

### **4.2 Configuration and peripherals**



\*Cabling and setup were taken into consideration and test data was taken under worse case conditions.

**Description of EUT and Support equipment**

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Cellular Phone	SH-03D	004401113515338	Sharp Corporation	EUT
B	microSD Memory Card	SD-C08G	0852K93900Y	Toshiba	-
C	Lithium-Ion Battery	Battery Pack SH27	-	Sharp Corporation	EUT
D	Desktop Holder	SH35	-	Sharp Corporation	EUT
E	Personal Computer	PP11L	CN-0D4571-48643-58P-1053	DELL	-
F	Mouse	M-UAG120	G83C0007F310	Toshiba	-
G	AC Adapter (PC)	PA-1650-05D2	CN-0F7970-71615-77H-0D63	DELL	-
H	Printer	C6410A	8G8BA1W18J	Hewlett Packard	-
I	AC Adaptor(Printer)	AT-3018A-0101	C4557-60004	Hewlett Packard	-
J	AC Adaptor(set)	MAS-BH0008-A002	-	NEC	-

**List of cables used**

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	USB Data Cable	0.80	Shielded	Shielded	-
2	Mouse Cable	0.71	Shielded	Shielded	-
3	Printer Cable	2.00	Shielded	Shielded	-
4	DC Power Cable(Printer)	2.00	Unshielded	Unshielded	-
5	AC Power Cable(Printer)	1.80	Unshielded	Unshielded	-
6	DC Power Cable(PC)	1.80	Unshielded	Unshielded	-
7	AC Power Cable(PC)	0.90	Unshielded	Unshielded	-
8	DC Power Cable(Set)	1.5	Unshielded	Unshielded	-
9	AC Power Cable(Set)	0.56 2.00 *1)	Unshielded	Unshielded	-

\*1) Used for Conducted emission test only.

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## **SECTION 5: Conducted Emission**

### **5.1 Operating environment**

Test place : No.1 semi anechoic chamber.  
Temperature : See data  
Humidity : See data

### **5.2 Test configuration**

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT and its peripherals was aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from the LISN/AMN and excess AC cable was bundled in center. I/O cables that were connected to the other peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. Each EUT current-carrying power lead, except the ground (safety) lead, was individually connected through a LISN/AMN to the input power source. All unused 50 ohm connectors of the LISN/AMN were resistivity terminated in 50 ohm when not connected to the measuring equipment. Photographs of the set up are shown in Appendix 1.

Frequency range : 0.15 MHz-30MHz  
EUT position : Table top  
EUT operation mode : See Clause 4.1

### **5.3 Test procedure**

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT within a semi anechoic chamber. The EUT was connected to a Line Impedance Stabilization Network (LISN)/ Artificial Mains network (AMN). An overview sweep with peak detection has been performed. The measurements have been performed with a quasi-peak detector and if required, with an average detector.

The conducted emission measurements were made with the following detector function of the test receiver.

Detector Type : Quasi-Peak and Average  
IF Bandwidth : 9 kHz

### **5.4 Test result**

Summary of the test results: Pass

Date: October 13, 2011

Test engineer: Hiroshi Kukita

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## **SECTION 6: Radiated Emission**

### **6.1 Operating environment**

Test place : No.1 semi anechoic chamber  
Temperature : See data  
Humidity : See data

### **6.2 Test configuration**

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane. The EUT was set on the edge of the tabletop.  
Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength. Photographs of the set up are shown in Appendix 1.

### **6.3 Test conditions**

Frequency range : 30MHz-300MHz (Biconical antenna) / 300MHz-1000MHz (Logperiodic antenna)  
1000MHz - 7000MHz (Horn antenna)  
Test distance : 3m  
EUT position : Table top  
EUT operation mode : See Clause 4.1

### **6.4 Test procedure**

The height of the measuring antenna varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.  
The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.  
The radiated emission measurements were made with the following detector function of the test receiver and the Spectrum analyzer.

Frequency	Below 1GHz	Above 1GHz
Instrument used	Test Receiver	Spectrum Analyzer
IF Bandwidth	QP: BW 120kHz	PK: RBW:1MHz/VBW: 3MHz AV *1): RBW:1MHz/VBW:10Hz

\*1) When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

- The test was made on EUT at the normal use position.

### **6.5 Test result**

Summary of the test results: Pass

Date: October 13, 2011

Test engineer: Hiroshi Kukita

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**APPENDIX 1: Data of EMI test**

**Conducted Emission**

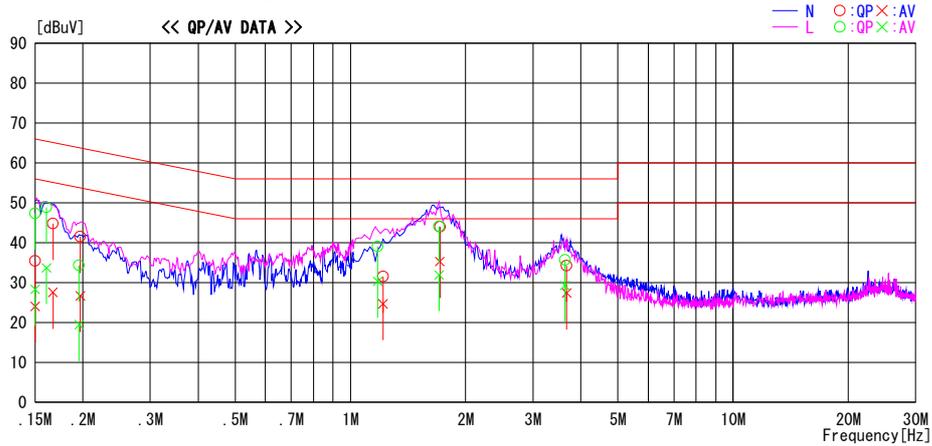
**DATA OF CONDUCTED EMISSION TEST**

UL Japan, Inc. Head Office EMC Lab. No.1 Semi Anechoic Chamber  
Date : 2011/10/13

Report No. : 31JE0238-H0  
Temp./Humi. : 23deg. C / 51% RH  
Engineer : Hiroshi Kukita

Mode / Remarks : USB Data Com Mode

LIMIT : FCC15.107(a) QP ClassB  
FCC15.107(a) AV ClassB



Frequency [MHz]	Reading Level		Corr. Factor [dB]	Results		Limit		Margin		Phase	Comment
	QP [dBuV]	AV [dBuV]		QP [dBuV]	AV [dBuV]	QP [dBuV]	AV [dBuV]	QP [dB]	AV [dB]		
0.15000	22.3	10.9	13.2	35.5	24.1	66.0	56.0	30.5	31.9	N	
0.16705	31.6	14.4	13.2	44.8	27.6	65.1	55.1	20.3	27.5	N	
0.19688	28.4	13.5	13.2	41.6	26.7	63.7	53.7	22.1	27.0	N	
1.21691	18.2	11.3	13.4	31.6	24.7	56.0	46.0	24.4	21.3	N	
1.71210	30.4	21.7	13.6	44.0	35.3	56.0	46.0	12.0	10.7	N	
3.67356	20.4	13.5	13.9	34.3	27.4	56.0	46.0	21.7	18.6	N	
0.15000	34.2	15.1	13.2	47.4	28.3	66.0	56.0	18.6	27.7	L	
0.16059	35.7	20.5	13.2	48.9	33.7	65.4	55.4	16.5	21.7	L	
0.19559	21.2	6.3	13.2	34.4	19.5	63.8	53.8	29.4	34.3	L	
1.17861	25.7	16.9	13.4	39.1	30.3	56.0	46.0	16.9	15.7	L	
1.70560	30.5	18.4	13.6	44.1	32.0	56.0	46.0	11.9	14.0	L	
3.63717	21.9	15.5	13.8	35.7	29.3	56.0	46.0	20.3	16.7	L	

CHART:WITH FACTOR, Peak hold data. CALCULATION:RESULT[dBuV]=READING[dBuV]+C.F[dB] (LISN LOSS+CABLE LOSS+ATTEN)  
Except for the above table : adequate margin data below the limits.

\*The test result is rounded off to one or two decimal places, so some differences might be observed.

## Conducted Emission

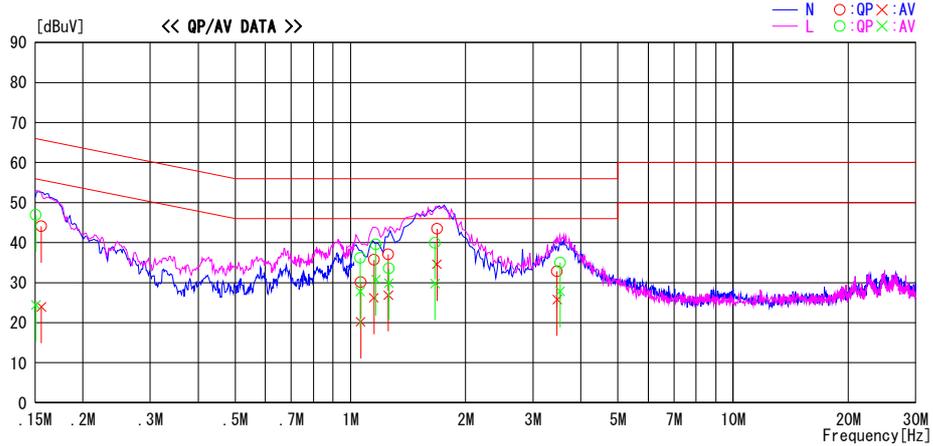
### DATA OF CONDUCTED EMISSION TEST

UL Japan, Inc. Head Office EMC Lab. No.1 Semi Anechoic Chamber  
Date : 2011/10/13

Report No. : 31JE0238-H0  
Temp./Humi. : 23deg. C / 51% RH  
Engineer : Hiroshi Kukita

Mode / Remarks : Standby Mode

LIMIT : FCC15.107(a) QP ClassB  
FCC15.107(a) AV ClassB



Frequency [MHz]	Reading Level		Corr. Factor [dB]	Results		Limit		Margin		Phase	Comment
	QP [dBuV]	AV [dBuV]		QP [dBuV]	AV [dBuV]	QP [dBuV]	AV [dBuV]	QP [dB]	AV [dB]		
0.15581	30.9	10.8	13.2	44.1	24.0	65.7	55.7	21.6	31.7	N	
1.06355	16.7	6.8	13.4	30.1	20.2	56.0	46.0	25.9	25.8	N	
1.15212	22.3	12.8	13.4	35.7	26.2	56.0	46.0	20.3	19.8	N	
1.25567	23.7	13.5	13.4	37.1	26.9	56.0	46.0	18.9	19.1	N	
1.68345	29.9	21.0	13.6	43.5	34.6	56.0	46.0	12.5	11.4	N	
3.46583	19.0	12.0	13.8	32.8	25.8	56.0	46.0	23.2	20.2	N	
0.15068	33.7	11.2	13.2	46.9	24.4	66.0	56.0	19.1	31.6	L	
1.06176	22.8	14.4	13.4	36.2	27.8	56.0	46.0	19.8	18.2	L	
1.16505	26.2	17.4	13.4	39.6	30.8	56.0	46.0	16.4	15.2	L	
1.26120	20.1	16.4	13.5	33.6	29.9	56.0	46.0	22.4	16.1	L	
1.66304	26.3	16.2	13.6	39.9	29.8	56.0	46.0	16.1	16.2	L	
3.53372	21.2	14.1	13.8	35.0	27.9	56.0	46.0	21.0	18.1	L	

CHART: WITH FACTOR, Peak hold data. CALCULATION: RESULT [dBuV] = READING [dBuV] + C. F [dB] (LISN LOSS + CABLE LOSS + ATTEN)  
Except for the above table : adequate margin data below the limits.

\*The test result is rounded off to one or two decimal places, so some differences might be observed.

## Radiated Emission

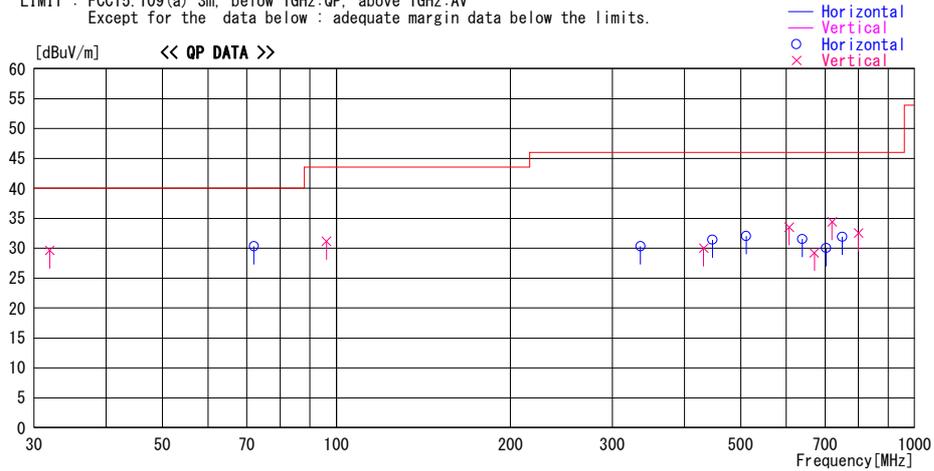
### DATA OF RADIATED EMISSION TEST

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Date : 2011/10/13

Report No. : 31JE0238-HO  
Temp./Humi. : 23deg. C / 51% RH  
Engineer : Hiroshi Kukita

Mode / Remarks : USB Data Com Mode, Normal Axis

LIMIT : FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:AV  
Except for the data below : adequate margin data below the limits.



Frequency [MHz]	Reading [dBuV]	DET	Antenna		Level [dBuV/m]	Angle [Deg]	Height [cm]	Polar.	Limit [dBuV/m]	Margin [dB]	Comment
			Factor [dB/m]	Loss& Gain [dB]							
31.955	43.0	QP	17.6	-31.0	29.6	203	100	Vert.	40.0	10.4	
72.027	54.3	QP	6.6	-30.6	30.3	120	251	Hori.	40.0	9.7	
96.135	52.1	QP	9.2	-30.2	31.1	154	100	Vert.	43.5	12.4	
335.993	42.3	QP	15.5	-27.5	30.3	286	100	Hori.	46.0	15.7	
431.989	38.8	QP	17.7	-26.5	30.0	22	137	Vert.	46.0	16.0	
447.362	39.9	QP	17.9	-26.4	31.4	128	100	Hori.	46.0	14.6	
511.271	39.5	QP	18.4	-25.9	32.0	177	100	Hori.	46.0	14.0	
607.134	39.1	QP	19.4	-25.0	33.5	0	100	Vert.	46.0	12.5	
639.089	36.6	QP	19.7	-24.8	31.5	152	118	Hori.	46.0	14.5	
671.043	33.7	QP	20.0	-24.5	29.2	355	100	Vert.	46.0	16.8	
702.996	34.0	QP	20.3	-24.3	30.0	145	100	Hori.	46.0	16.0	
719.984	37.9	QP	20.6	-24.1	34.4	78	100	Vert.	46.0	11.6	
750.000	34.6	QP	21.2	-23.9	31.9	84	100	Hori.	46.0	14.1	
800.000	34.0	QP	22.1	-23.6	32.5	72	189	Vert.	46.0	13.5	

CHART: WITH FACTOR ANT TYPE: -30MHz: LOOP, 30-300MHz: BICONICAL, 300MHz-1000MHz: LOGPERIODIC, 1000MHz-: HORN  
CALCULATION: RESULT = READING + ANT FACTOR + LOSS (CABLE+ATTEN.) - GAIN (AMP)

\*The limit is rounded down to one decimal place.

\*The test result is rounded off to one or two decimal places, so some differences might be observed.

## Radiated Emission

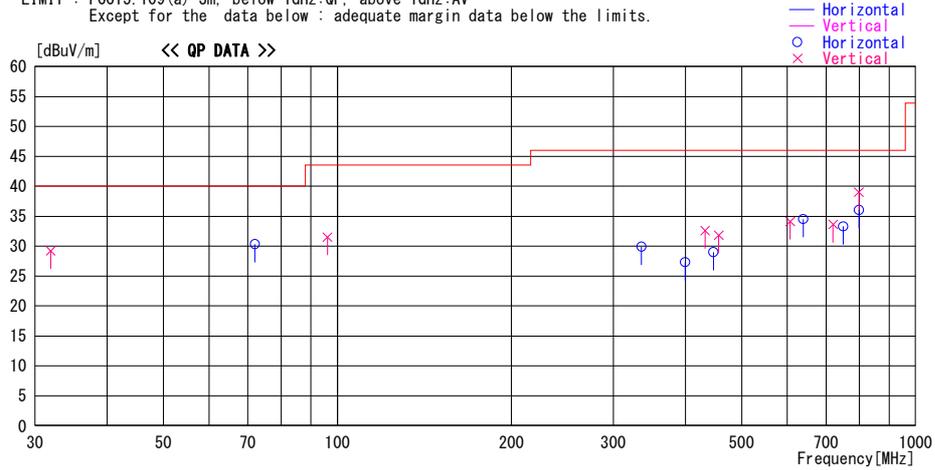
### DATA OF RADIATED EMISSION TEST

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Date : 2011/10/13

Report No. : 31JE0238-HO  
Temp./Humi. : 23deg. C / 51% RH  
Engineer : Hiroshi Kukita

Mode / Remarks : Standby Mode, Normal Axis

LIMIT : FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:AV  
Except for the data below : adequate margin data below the limits.



Frequency [MHz]	Reading [dBuV]	DET	Antenna	Loss&	Level	Angle	Height	Polar.	Limit	Margin	Comment
			Factor [dB/m]	Gain [dB]							
31.956	42.6	QP	17.6	-31.0	29.2	210	100	Vert.	40.0	10.8	
72.028	54.3	QP	6.6	-30.6	30.3	114	238	Hori.	40.0	9.7	
96.136	52.5	QP	9.2	-30.2	31.5	147	100	Vert.	43.5	12.0	
335.993	41.9	QP	15.5	-27.5	29.9	266	100	Hori.	46.0	16.1	
399.848	36.6	QP	17.5	-26.8	27.3	179	100	Hori.	46.0	18.7	
432.604	41.4	QP	17.7	-26.5	32.6	148	100	Vert.	46.0	13.4	
447.361	37.5	QP	17.9	-26.4	29.0	130	100	Hori.	46.0	17.0	
456.637	40.1	QP	17.9	-26.2	31.8	171	100	Vert.	46.0	14.2	
607.135	39.7	QP	19.4	-25.0	34.1	327	100	Vert.	46.0	11.9	
639.091	39.6	QP	19.7	-24.8	34.5	143	118	Hori.	46.0	11.5	
719.986	37.1	QP	20.6	-24.1	33.6	73	100	Vert.	46.0	12.4	
750.002	36.0	QP	21.2	-23.9	33.3	84	100	Hori.	46.0	12.7	
798.240	40.6	QP	22.0	-23.6	39.0	278	101	Vert.	46.0	7.0	
797.937	37.6	QP	22.0	-23.6	36.0	315	100	Hori.	46.0	10.0	

CHART:WITH FACTOR ANT TYPE: -30MHz:LOOP, 30-300MHz:BICONICAL, 300MHz-1000MHz:LOGPERIODIC, 1000MHz:-HORN  
CALCULATION:RESULT = READING + ANT FACTOR + LOSS(CABLE+ATTEN.) - GAIN(AMP)

\*The limit is rounded down to one decimal place.

\*The test result is rounded off to one or two decimal places, so some differences might be observed.

## Radiated Emission

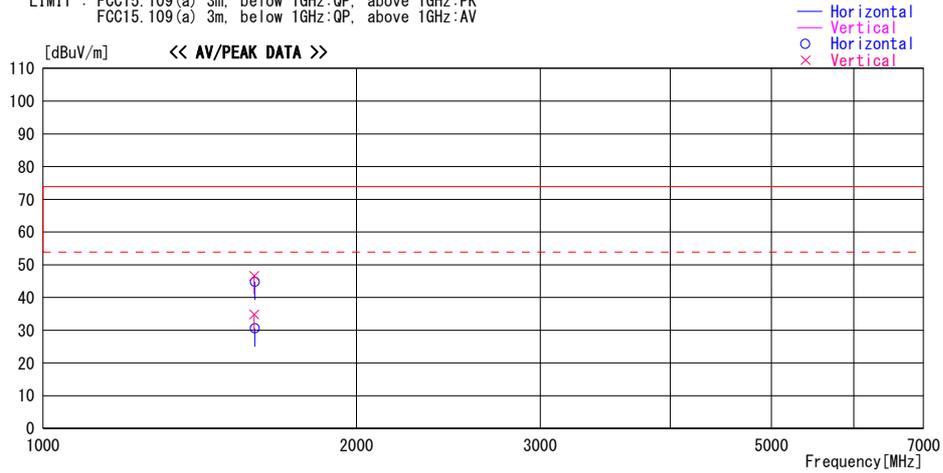
### DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Head Office EMC Lab. No.1 Semi Anechoic Chamber  
Date : 2011/10/13

Report No. : 31JE0238-HO...  
Temp./Humi. : 23deg. C / 51% RH  
Engineer : Hiroshi Kukita

Mode / Remarks : USB Data Com Mode, Normal Axis

LIMIT : FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:PK  
FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:AV



Frequency [MHz]	Reading [dBuV]	DET	Antenna	Loss&	Level	Angle	Height	Polar.	Limit	Margin	Comment
			Factor [dB/m]	Gain [dB]							
1596.917	53.4	PK	26.2	-34.8	44.8	45	100	Hori.	73.9	29.1	
1595.333	55.2	PK	26.2	-34.8	46.6	221	100	Vert.	73.9	27.3	
1595.333	43.4	AV	26.2	-34.8	34.8	221	100	Vert.	53.9	19.1	
1596.917	39.2	AV	26.2	-34.8	30.6	45	100	Hori.	53.9	23.3	

CHART:WITH FACTOR ANT TYPE: -30MHz:LOOP, 30-300MHz:BICONICAL, 300MHz-1000MHz:LOGPERIODIC, 1000MHz:-HORN  
CALCULATION:RESULT = READING + ANT FACTOR + LOSS(CABLE+ATTEN.) - GAIN(AMP)

\*The limit is rounded down to one decimal place.  
\*The test result is rounded off to one or two decimal places, so some differences might be observed.

## Radiated Emission

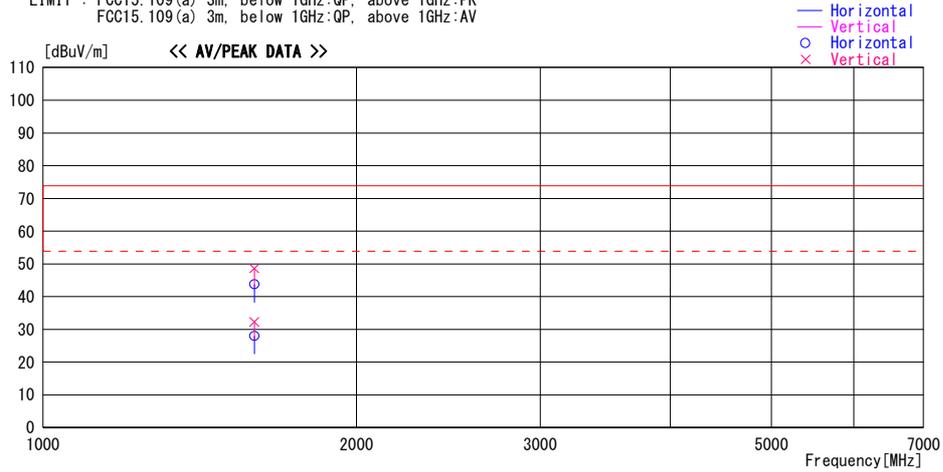
### DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Head Office EMC Lab. No.1 Semi Anechoic Chamber  
Date : 2011/10/13

Report No. : 31JE0238-H0  
Temp./Humi. : 23deg. C / 51% RH  
Engineer : Hiroshi Kukita

Mode / Remarks : Standby Mode, Normal Axis

LIMIT : FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:PK  
FCC15.109(a) 3m, below 1GHz:QP, above 1GHz:AV



Frequency [MHz]	Reading [dBuV]	DET	Antenna	Loss&	Level [dBuV/m]	Angle [Deg]	Height [cm]	Polar.	Limit	Margin	Comment
			Factor [dB/m]	Gain [dB]					[dBuV/m]	[dB]	
1596.033	57.2	PK	26.2	-34.8	48.6	76	100	Vert.	73.9	25.3	
1596.033	40.9	AV	26.2	-34.8	32.3	76	100	Vert.	53.9	21.6	
1596.083	52.4	PK	26.2	-34.8	43.8	233	100	Hori.	73.9	30.1	
1596.083	36.6	AV	26.2	-34.8	28.0	233	100	Hori.	53.9	25.9	

CHART: WITH FACTOR ANT TYPE: -30MHz: LOOP, 30-300MHz: BICONICAL, 300MHz-1000MHz: LOGPERIODIC, 1000MHz-: HORN  
CALCULATION: RESULT = READING + ANT FACTOR + LOSS(CABLE+ATTEN.) - GAIN(AMP)

\*The limit is rounded down to one decimal place.

\*The test result is rounded off to one or two decimal places, so some differences might be observed.

## **APPENDIX 2: Test instruments**

### **EMI Test Instruments**

<b>Control No.</b>	<b>Instrument</b>	<b>Manufacturer</b>	<b>Model No</b>	<b>Serial No</b>	<b>Test Item</b>	<b>Calibration Date * Interval(month)</b>
MAEC-01	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 10m	DA-06881	RE/CE	2011/07/10 * 12
MOS-01	Digital Humidity Indicator	N.T	NT-1800	MOS01	RE/CE	2011/02/23 * 12
MJM-01	Measure	KDS	ES19-55	-	RE/CE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE/CE	-
MTR-01	Test Receiver	Rohde & Schwarz	ESI40	100084	RE/CE	2010/12/07 * 12
KBA-05	Biconical Antenna	Schwarzbeck	BBA9106	2513	RE	2011/09/10 * 12
KLA-04	Logperiodic Antenna	Schwarzbeck	USLP9143	361	RE	2011/08/17 * 12
MAT-08	Attenuator(6dB)	Weinschel Corp	2	BK7971	RE	2010/11/05 * 12
MCC-02	Coaxial Cable	Suhner/storm/Agilent/T SJ	-	-	RE	2011/09/17 * 12
MPA-19	Pre Amplifier	MITEQ	MLA-10K01-B01-35	1237616	RE	2011/02/28 * 12
MHA-05	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	253	RE	2011/06/19 * 12
MCC-134	Microwave Cable	HUBER+SUHNER	SUCOFLEX104	336167/4(1m) / 340641(5m)	RE	2011/09/07 * 12
MPA-01	Pre Amplifier	Agilent	8449B	3008A01671	RE	2011/02/24 * 12
MLS-02	LISN(AMN)	Schwarzbeck	NSLK8127	8127383	CE(EUT)	2011/07/11 * 12
MLS-03	LISN(AMN)	Schwarzbeck	NSLK8127	8127384	CE(AE)	2011/07/11 * 12
MTA-30	Terminator	TME	CT-01	-	CE	2011/01/05 * 12
MCC-03	Coaxial Cable	Fujikura/Suhner/TSJ	5D-2W(20m)/3D-2W(7.5m)/RG400u(1.5m)/RFM-E421(Switcher)	- /01068(Switcher)	CE	2011/01/16 * 12
MAT-64	Attenuator(13dB)	JFW Industries, Inc.	50FP-013H2 N	-	CE	2011/02/22 * 12
MSA-04	Spectrum Analyzer	Agilent	E4448A	US44300523	RE	2011/04/08 * 12

**The expiration date of the calibration is the end of the expired month.**

**All equipment is calibrated with traceable calibrations. Each calibration is traceable to the national or international standards.**

**As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.**

#### **Test Item:**

**CE: Conducted Emissions**

**RE: Radiated Emissions**

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